

# TEST REPORT

**Applicant:** Shenzhen Ariza Electronic Co., Ltd  
**Address:** The 2nd floor of B1 building, Xingfu industry zone, Chongqing Rd., Heping village Fuyong Town, Bao'an district, Shenzhen, China  
**Equipment Type:** PCB Antenna  
**Model Name:** Finein Tag  
**Brand Name:** N/A  
**Test Standard:** IEEE Std 149-2021  
**Sample Arrival Date:** Dec. 13, 2023  
**Test Date:** Dec. 15, 2023  
**Date of Issue:** Dec. 19, 2023

**ISSUED BY:**

Shenzhen BALUN Technology Co., Ltd.



**Tested by:** Mai Jintian

**Checked by:** Xia Long

**Approved by:** Tolan Tu  
(Testing Director)

*Mai Jintian*

*Xia Long*

*Tolan Tu*

<b>Revision History</b>		
Version	Issue Date	Revisions
<u>Rev. 01</u>	<u>Dec. 19, 2023</u>	<u>Initial Issue</u>

## TABLE OF CONTENTS

1	GENERAL INFORMATION .....	3
1.1	Test Laboratory .....	3
1.2	Test Location.....	3
2	PRODUCT INFORMATION.....	4
2.1	Applicant Information .....	4
2.2	Manufacturer Information .....	4
2.3	General Description for Equipment under Test (EUT) .....	4
2.4	Ancillary Equipment .....	4
2.5	Technical Information.....	4
3	SUMMARY OF TEST RESULTS.....	5
3.1	Test Standards.....	5
3.2	Test Verdict .....	5
3.3	Test Uncertainty .....	5
4	GENERAL TEST CONFIGURATIONS.....	6
4.1	Test Condition .....	6
4.2	Test Equipment List .....	6
4.3	Test Setup.....	7
ANNEX A	TEST RESULTS.....	8
A.1	Gain and Efficiency .....	8
A.2	VSWR .....	9
ANNEX B	RADIATION PATTERN.....	10
ANNEX C	TEST SETUP PHOTOS .....	13
ANNEX D	EUT PHOTO .....	13

# 1 GENERAL INFORMATION

## 1.1 Test Laboratory

Name	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

## 1.2 Test Location

Name	Shenzhen BALUN Technology Co., Ltd.
Location	<input checked="" type="checkbox"/> Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
	<input type="checkbox"/> 1/F, Building B, Ganghongji High-tech Intelligent Industrial Park, No. 1008, Songbai Road, Yangguang Community, Xili Sub-district, Nanshan District, Shenzhen, Guangdong Province, P. R. China

## 2 PRODUCT INFORMATION

### 2.1 Applicant Information

Applicant	Shenzhen Ariza Electronic Co., Ltd
Address	The 2nd floor of B1 building, Xingfu industry zone, Chongqing Rd., Heping village Fuyong Town, Bao'an district, Shenzhen, China

### 2.2 Manufacturer Information

Manufacturer	Shenzhen Ariza Electronic Co., Ltd
Address	The 2nd floor of B1 building, Xingfu industry zone, Chongqing Rd., Heping village Fuyong Town, Bao'an district, Shenzhen, China

### 2.3 General Description for Equipment under Test (EUT)

EUT Name	PCB Antenna
Model Name Under Test	Finein Tag
Antenna Type	PCB Antenna
Dimensions	10.0*4.5 mm

### 2.4 Ancillary Equipment

Note: Not applicable.

### 2.5 Technical Information

Test Frequencies	2400MHz, 2410MHz, 2420MHz, 2430MHz, 2440MHz, 2450MHz, 2460MHz, 2470MHz, 2480MHz, 2490MHz, 2500MHz
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### 3 SUMMARY OF TEST RESULTS

#### 3.1 Test Standards

No.	Identity	Document Title
1	IEEE Std 149-2021	IEEE Standard Test Procedures for Antennas

#### 3.2 Test Verdict

Report Section	Description	Remark
ANNEX A.1	Gain and Efficiency	--
ANNEX A.2	VSWR	--
ANNEX B	Radiation Pattern	--

#### 3.3 Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Item	Uncertainty
Gain	$\pm 1.92\text{dB}$
VSWR(S11)	$\pm 0.61$

## 4 GENERAL TEST CONFIGURATIONS

### 4.1 Test Condition

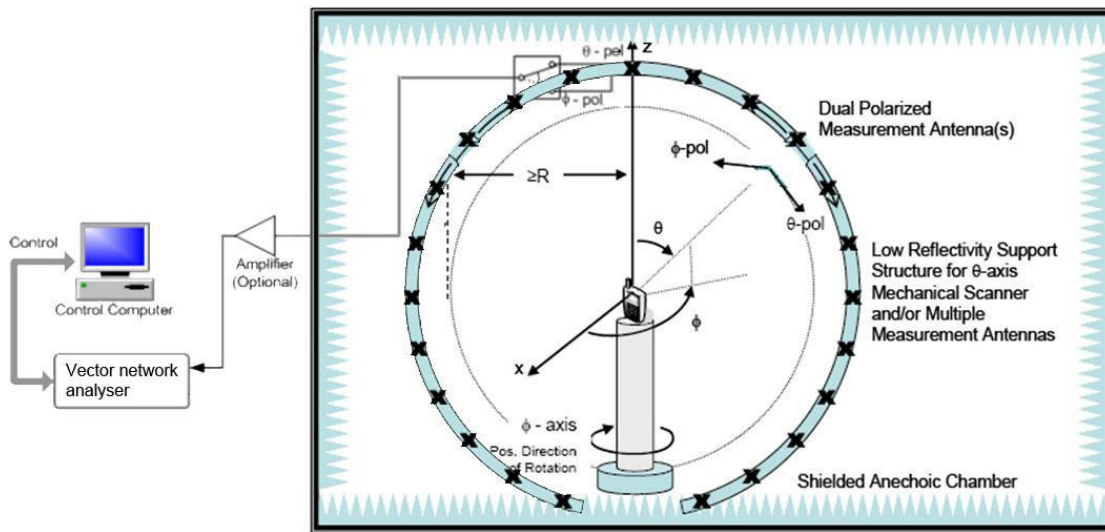
Environment Parameter	Selected Values During Tests			
	Ambient Pressure (KPa)	Temperature (°C)	Voltage	Relative Humidity (%)
Normal Temperature, Normal Voltage (NTNV)	101	21.7	N/A	46

### 4.2 Test Equipment List

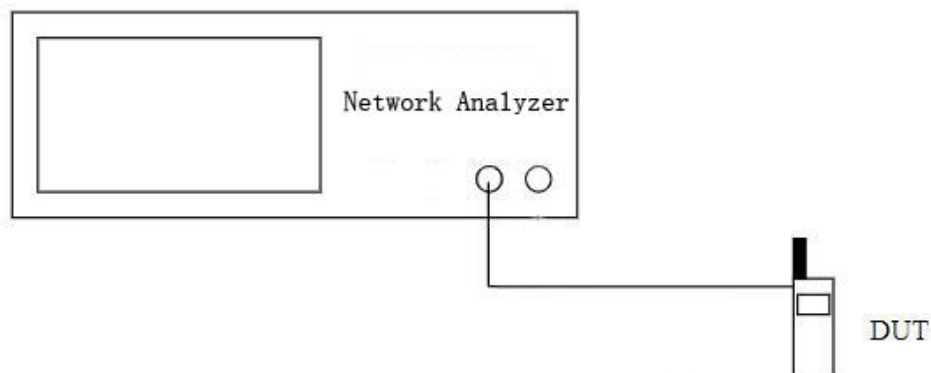
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due
SG24 Multi-probe Antenna Measurement System	SATIMO	SG24-L	1101855-0001	2021.11.12	2024.11.11
Vector Network Analyzer	Agilent	E5071B	MY42404001	2023.03.26	2024.03.25
Description	Manufacturer	Name		Version	
Test Software	MVG	SPM		V 1.8	

### 4.3 Test Setup

#### 4.3.1 Antenna gain, efficiency and radiation pattern test setup



#### 4.3.2 S11 parameter test setup



## ANNEX A TEST RESULTS

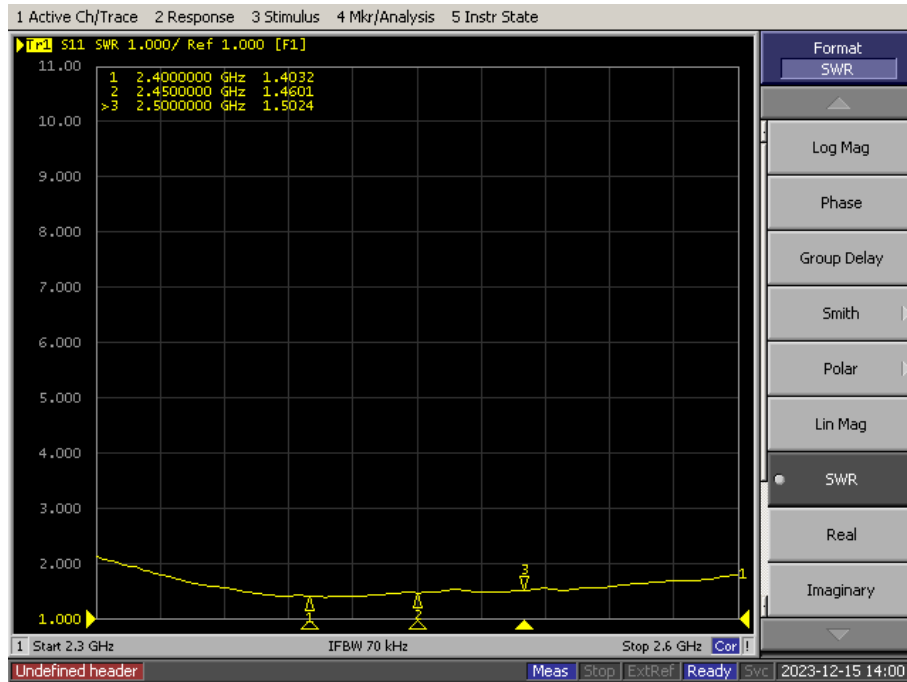
### A.1 Gain and Efficiency

Frequency	Gain (dBi)	Efficiency (%)
2400MHz	1.10	39
2410MHz	0.75	37
2420MHz	0.79	37
2430MHz	1.15	40
2440MHz	1.21	40
2450MHz	1.39	41
2460MHz	1.54	41
2470MHz	1.61	42
2480MHz	1.67	42
2490MHz	<b>1.71</b>	42
2500MHz	1.64	<b>43</b>



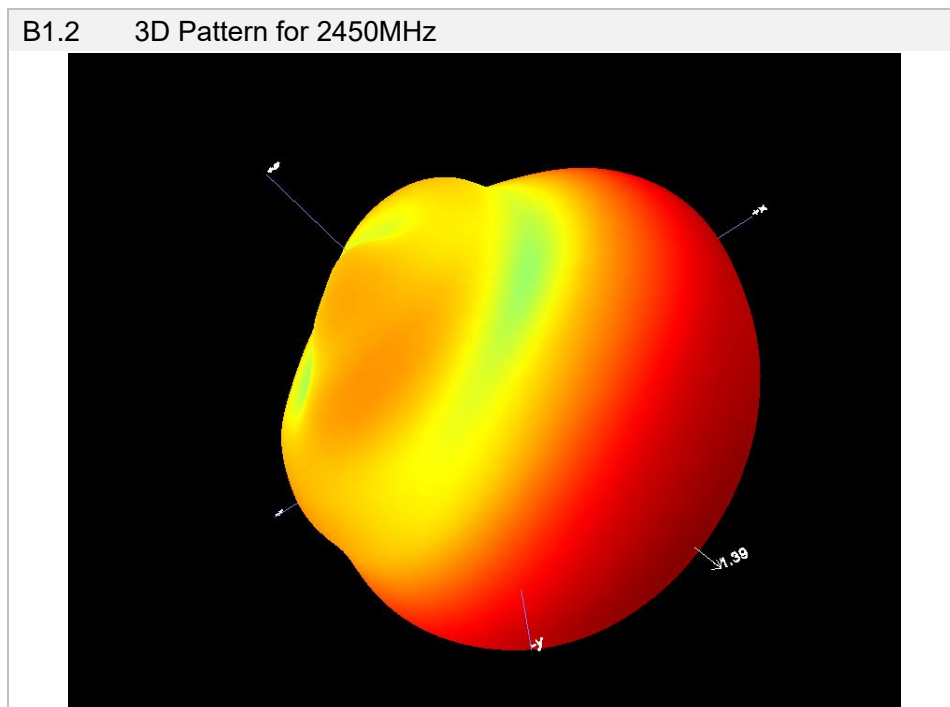
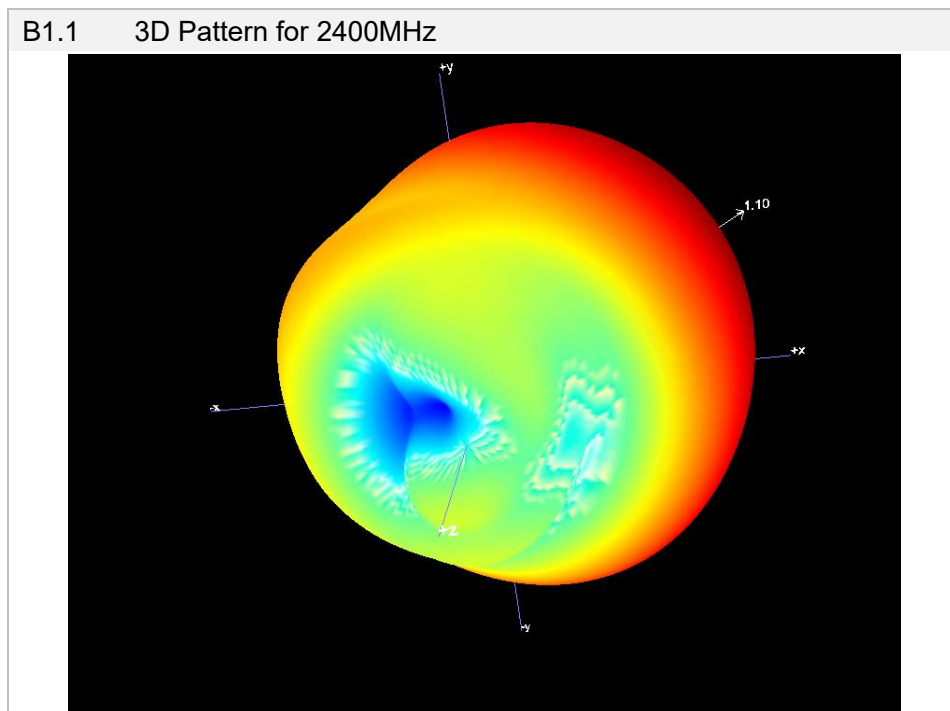
## A.2 VSWR

Frequency	SWR
2400MHz	1.40
2450MHz	1.46
2500MHz	1.50

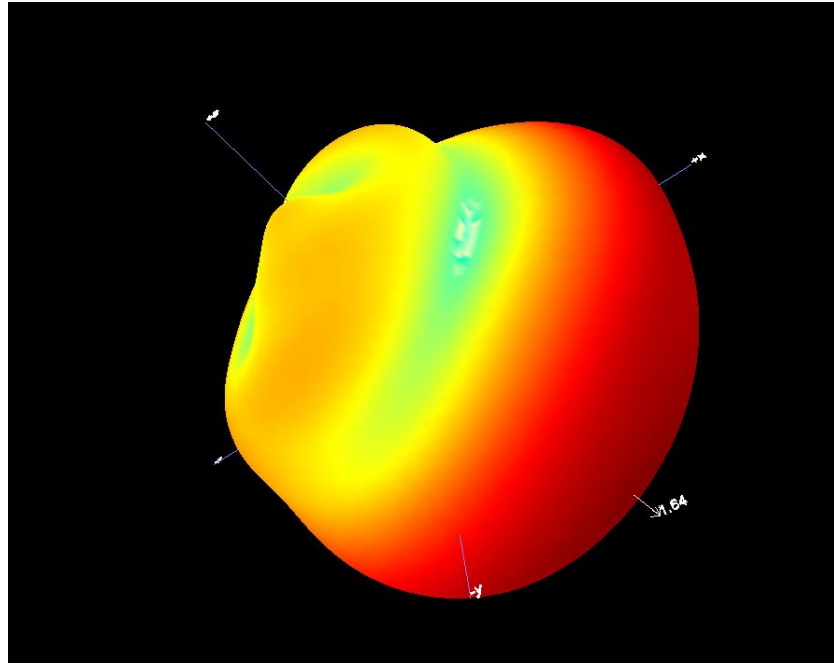


## ANNEX B RADIATION PATTERN

### B.1 3D Pattern

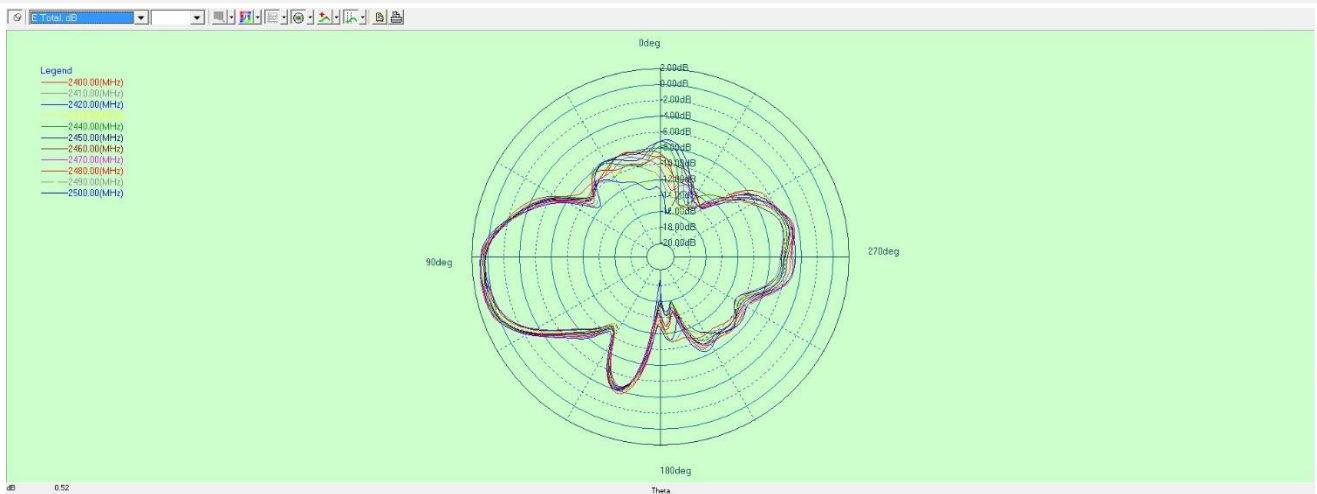


B1.3 3D Pattern for 2500MHz

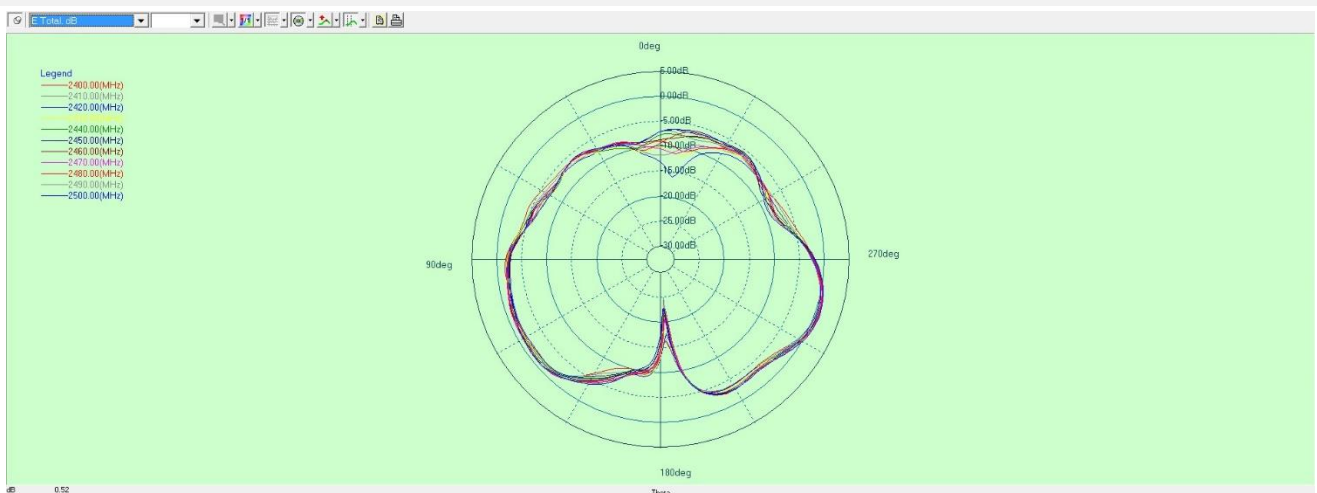


## B.2 1D Radiation Pattern

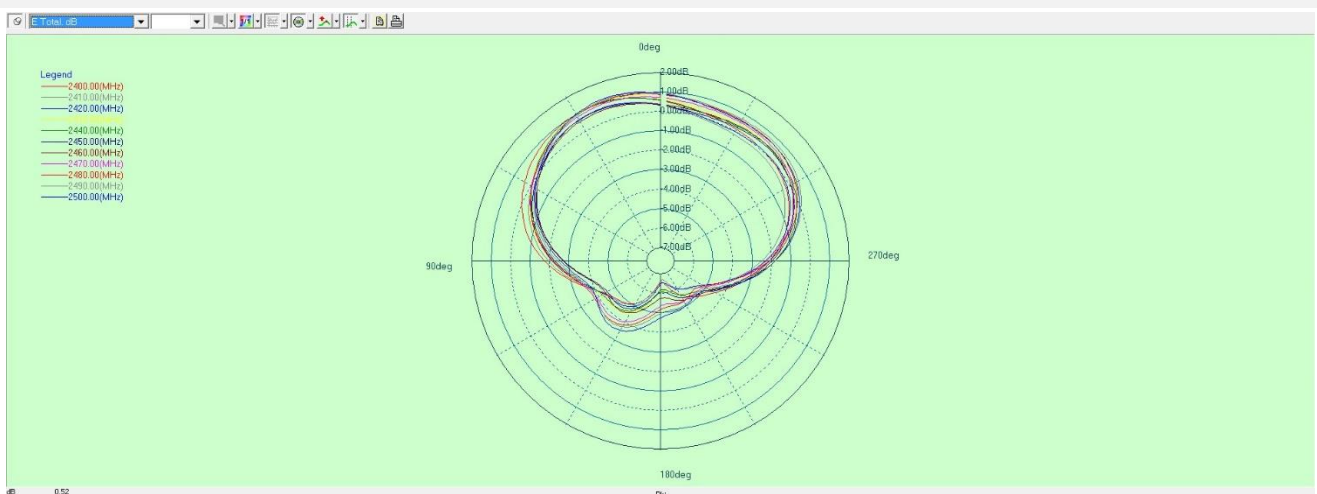
### B2.1 PHI=0



### B2.2 PHI=90



### B2.3 THETA=90



## **ANNEX C TEST SETUP PHOTOS**

Please refer the document “BL-SZ23C0706-AO-1.PDF”.

## **ANNEX D EUT PHOTO**

Please refer the document “BL-SZ23C0706-AA-1.PDF”.

## Statement

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--END OF REPORT--